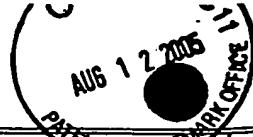


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 265122US90PCT		SERIAL NO. 10/522,552	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT			Takashi IMAEDA, et al.			
		FILING DATE			GROUP			
January 27, 2005								
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME		CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AA								
AB								
AC								
AD								
AE								
AF								
AG								
AH								
AI								
AJ								
AK								
AL								
AM								
AN								
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES      NO		
/AL/	AO	2000-330957	11/30/00	JP(with English abstract)				NO
/AL/	AP	8-235116	09/13/96	JP(with English abstract)				NO
	AQ							
	AR							
	AS							
	AT							
	AU							
	AV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
/AL/	AW	Junji KURODA et al., "Mitsubishi EDI Package 'EDIFOAS/Web'", Mitsubishi Denki Giho, Vol. 72, No. 2, pages 36 to 39, February 25, 1998.						
/AL/	AX	Yutaka SATO, "Tamokuteki Proxy Server Dele Gate no Kino Shosai", Interface, Vol. 21, No. 9, pages 130 to 146, September 1, 1995.						
	AY							
	AZ						<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Andalib Lodhi/					Date Considered 03/12/2007			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								



Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 265122US90PCT	SERIAL NO. 10/522,552		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Takashi IMAEDA, et al.					
		FILING DATE January 27, 2005		GROUP			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/AL/	AA	2003/0217079	11/20/03	BAKALASH, Reuven et al.			
	AB	2002/0184187	12/05/02	BAKALASH, Reuven et al.			
	AC	2003/0129032	07/10/03	HYATT, Gregory Aaron et al.			
	AD	2002/0116364	08/22/02	SEKI, Yumiko et al.			
	AE	2002/0099691	07/25/02	LORE, Michael Dean et al.			
	AF	6,393,472	05/21/02	ANEROUSIS, Nikolaos et al.			
/AL/	AG	2002/0029207	03/07/02	BAKALASH, Reuven et al.			
	AH						
	AI						
	AJ						
	AK						
	AL						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
/AL/	AM	2002-183094	06/28/02	JP(with English abstract)	YES		NO
	AN	2001-273258	10/05/01	JP(with English abstract)			NO
	AO	2001-265747	09/28/01	JP(with English abstract)			NO
	AP	2000-181980	06/30/00	JP(with English abstract)			NO
	AQ	11-212911	08/06/99	JP(with English abstract)			NO
	AR	2002-163235	06/07/02	JP(with English abstract)			NO
	AS	2001-101054	04/13/01	JP(with English abstract)			NO
	AT	10-303947	11/13/98	JP(with English abstract)			NO
	AU	2 401 348	09/13/01	CA(with English abstract)			NO
/AL/	AV	02/19229	03/07/02	WO			NO
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner /Andalib Lodhi/					Date Considered 03/12/2007		
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